

**Comparative study: The effects of solvent on the
morphology, optical and structural features of regioregular
poly(3-hexylthiophene): fullerene thin films**

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ABSTRACT

In this report the effect of solvent to control the degree of mixing of the polymer and fullerene components, as well as the domain size and charge transport properties of the blends were investigated in detail using P3HT:C₆₀ films. Films spin coated from a faster evaporating solvent such as an aromatic solvents demonstrate an improved ordering and a higher surface roughness in P3HT and blended films indicating that the limited solubility of P3HT:C₆₀ in a marginal solvent can lead directly to optimal morphologies on the films. The PL quenched by a factor of 3 after blending the P3HT with C₆₀ in a 1:1 wt. ratio using CB, xylene, DCB, and toluene as solvents, indicating a partially charge transfer from P3HT to C₆₀.

Keywords: Poly-3-hexylthiophene, fullerene, polymer solar cells, morphology

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1. INTRODUCTION

In the last decade, solution processible organic conducting and semiconducting polymers have been extensively studied for use in organic solar cells due to their low-cost synthesis, low thermal budget and direct-writing printing techniques [1-4]. However, various properties of conducting polymers such as the charge mobility and electrical conductivity need to be improved in order to achieve the performance level of solar cells based on its inorganic crystalline and amorphous counterparts.

Poly(3-hexylthiophene) (P3HT) is a widely used organic semiconductor and therefore it is a good candidate for application in polymer solar cells [5]. P3HT shows good environmental stability [6], proper field-effect mobility of 0.01- 0.1 cm²/Vs, reasonably high hole mobility in the range of 10⁻³ cm² V⁻¹ s⁻¹ [7], has an absorption edge around 1.9 - 2.0 eV [8] and has a high solubility (solution processability). The excellent mobility of P3HT is thought to be due to the lamella-type stacking of the side chains and the stacking of thiophene rings, and thus the strong interchain interactions [9, 10]. In the past few years the technology of polymer photovoltaics has seen some drastic improvements in their power conversion efficiency [11]. Power conversion efficiencies in the 5% range have been achieved [12,13] by optimizing the fabrication process, such as by annealing devices in a particular range of temperatures [13] or in a microwave oven [14] for an adequate period, or by carefully controlling the solvent evaporation rate [15] to induce the formation of a nanoscaled bi-continuous interpenetrating network with a high interfacial area to increase exciton dissociation

efficiency and the ordered stacking structure of the polymer chains and thereby enhance the charge mobility. For achieving such a high interfacial area, the electron acceptor material must have a high solubility in the organic solvent. Therefore, fullerene derivatives should be used as the electron acceptor for homogeneous, thin film formation from solutions with optical quality [16].

In spite of these recent works no unambiguous result as to the optimal processing for device performance has been established to date. In this paper the effect of solvent to control the degree of mixing of the polymer and fullerene components, as well as the domain size and charge transport properties of the blends were investigated in detail using P3HT: C₆₀ films with different weight ratios.

2. EXPERIMENT DETAILS

2.1 Sample preparation

Sample preparations were done according to the following procedure. All chemicals used in this experiment were purchased from Sigma Aldrich. Regioregular poly (3-hexylthiophene) (rr-P3HT) was used as a light absorption and electron donating material; while the C₆₀ fullerene was used as an electron acceptor material. The molecular weight (M_n) of P3HT reported by Sigma Aldrich was $\sim 64,000 \text{ g mol}^{-1}$; with regularity that is greater than 98.5 % for head-to-tail. Regioregularity denotes the percentage of stereo-regular head-to-tail (HT) attachments of the hexyl side chains to the

3-position of the thiophene rings [17]. These materials were used as received, without any further purification. Indium tin oxide (ITO) coated on a 1 mm glass substrate with a resistance between 8 and 12 Ωsq^{-1} , and silicon (Si) (100) substrates were successfully cleaned by consecutive ultrasonication in acetone, isopropanol and de-ionized water for 10 min and dried in dry nitrogen. The active layer (i.e. the layer in which the majority of the incident light is absorbed and charges are generated) containing rr-P3HT and C₆₀ with different weight ratios (P3HT: C₆₀, e.g. 1:0, 1:1 wt. ratio) was dissolved in 1mL of non-aromatic solvents (Tetrahydrofuran (THF) and Chloroform) and aromatic solvents (Dichlorobenzene (DCB), Toluene, Xylene and Chlorobenzene (CB) solutions). The solutions were stirred overnight on a hot plate at a temperature of 50 °C to promote a complete dissolution. P3HT and its blends with a thickness of about 100 nm were spin coated onto the ITO and Si substrates. The spinning rate and time of spin-coating were 2500 rpm and 30 s. The samples were dried on a hot plate at a temperature of 50 °C for 15 min.

2.2 Characterization

Atomic force microscope (AFM) (Veeco Digital Instruments Multimode), operating in the tapping mode using a phosphorus doped silicon cantilever with a spring constant of 40 Nm^{-1} and a tip radius of <10 nm, was used to characterize the morphology of the P3HT and its blend. The microstructure of the P3HT and its blends was studied with a Carl Zeiss Imager Z1M polarised optical microscope (POM). Spin-coated thin films were placed between two covering glasses and placed on a Linkam hot-stage (Linkam

Scientific Instruments Ltd, UK), mounted on a POM instrument. Samples were heated from room temperature up to 250 °C at a heating rate of 10 °Cmin⁻¹, held at 250 °C for 1 min and then cooled down to room temperature at a precisely controlled cooling rate of 10 °Cmin⁻¹. The films thickness was measured using a Veeco DEKTAK 6M Stylus profilometer.

The orientation and crystallinity of the P3HT and blends films spin-coated onto Si substrates, perhaps the most significant factors enhancing P3HT thin film properties, were characterized by Panalytical X'pert PRO PW 3040/60 x-ray diffractometer with a Cu K_α ($\lambda = 0.154$ nm) monochromated radiation source, operating at 45.0 kV and 40.0 mA. XRD data were collected in the 2θ ranging from 3 to 25° with a step size of 0.02°. The absorption spectra of the active layer of P3HT and C₆₀ organic layers were measured by a PerkinElmer Ultra Violet-Visible (UV-vis) spectrometer from 900 to 300 nm. For Photoluminescence (PL), Raman and Fourier transform infrared spectroscopy (FTIR) measurements; samples were spin-coated on Si substrates. The photoluminescence (PL) spectra were taken from 300 to 900 nm by exciting the samples with 350 nm line of deuterium lamp. The emission was detected with Jobin-Yvon PMT detector. The structural properties of P3HT and its blend were investigated by PerkinElmer Fourier transform infrared spectroscopy spectrometer and Horiba Jobin Yvon HR800 micro-Raman spectrometer in backscattering geometry at room temperature. The Raman spectra were collected in the region 100–3000 cm⁻¹ with a spectral resolution of 0.4 cm⁻¹, using an excitation wavelength of 514.5 nm which was directed perpendicular to the Si substrate.

3. RESULTS AND DISCUSSION

3.1. Morphology

Figure 1 shows the tapping-mode atomic force microscopy (AFM) images of the surface topography of as-prepared P3HT:C₆₀ (1:1 wt. ratio) films prepared from different solvents. The figures clearly reveal the different surface topographies between the films prepared from aromatic and non-aromatic solvents, illustrating that the surface topography is strongly dependent on the solvent used for spin-coating. The films spin-cast from non-aromatic solvents shows a high root mean square (rms) roughness (σ_{rms}) of 11.3 and 13.0 nm for chloroform and THF, respectively, where the films spin-cast from chloroform solvent (Fig. 1c) revealed nanorods, which are clearly resolved on the entire area of the scan. However, films spin-cast from the aromatic solvents exhibited a nearly smooth surface with a roughness of 0.84, 2.79, 1.71 and 4.56 nm for DCB, toluene, CB and xylene, respectively. Blend films prepared from non-aromatic solvents, which have quicker evaporation time, have a higher roughness than the films prepared from aromatic solvents.

The difference in roughness can also be attributed to the different solubility of C₆₀ (Table 1) in different solvents, which results in a different phase separation. Additionally, the high surface roughness in the films prepared from non-aromatic solvents is also most likely related to a signature of polymer reorganization, which in turn enhances ordered structure formation in the thin film and also increases the carrier mobility which could produce a higher efficiency from the devices. This can also be

related to the lower solubility of C_{60} (Table 1), which normally forms clusters around the film and act as better pathways for charge-carrier transport in the polymer phase [18].

The microstructure of the blends spin-coated on Si substrates and prepared from different solvents was studied using polarised optical microscopy (POM) technique. It is evident in Figure 2(a-c, e) that the films investigated at room temperature shows small aggregates which are related to C_{60} fullerene clusters embedded in a polymer-rich skin layer, while the films prepared from CB and DCB (inset in Fig 2g) shows no aggregates associated with C_{60} . This is due to their high solubility of C_{60} fullerene in CB and DCB. The observed C_{60} clusters, especially in the case of the THF and chloroform solutions are in good agreement with the high surface roughness observed in AFM results.

To study the effect of temperature on the P3HT: C_{60} (1:1 wt. ratio) films, the samples spin-cast from chloroform solvent were heated from room temperature to 250 °C at a heating rate of 10 °Cmin⁻¹, dwelled at 250 °C for 1 min and then cooled down to room temperature at a precisely controlled cooling rate of 10 °Cmin⁻¹. It can clearly be seen in Figure 2 (e-h) as well as on the inset (Fig. 2a) that, during heating treatment, the changes in colour visible of as-prepared film is observed. The changes in colour visible during this treatment may correspond to P3HT crystallization and a depletion of C_{60} which would occur between around 72 to 170 °C, followed by melting from 200 to 250 °C. At a temperature of 250 °C (Figure 2h), the surface of the

film became smoother and the aggregate domains, probably related to C₆₀ are invisible.

A similar behavior in colour change and a depletion of a soluble fullerene derivative, phenyl-C₆₁-butyric acid methyl ester (PCBM) around 250 °C was also observed by Campoy-Quiles et al. [21]. Differential scanning calorimetry (DSC) measurements showed that, rr-P3HT exhibit an exothermic transition from a crystalline to a liquid crystalline state around 229 °C [22]. Chen et al. [23] also showed a melting temperature of 240–245 °C for head-to-tail rr-P3HT. Previous experimental POM results [24] showed that during annealing the P3HT films and its blend exhibit larger stains (aggregate domains). An increase in aggregates related to C₆₀ clusters, diffused out of the polymer matrix during annealing.

3.2. Structural properties

To determine the structural information (chain orientation and crystallinity) of the P3HT film and its blend, the x-ray diffraction (XRD) measurements were carried out on the films spin-coated on Si (100) substrates. Figure 3 depicts the XRD patterns of the P3HT film as well as the blend of P3HT:C₆₀ (1:1 wt. ratio) prepared from different solvents. The P3HT polymer prepared from non-aromatic solvents such as chloroform and THF shows well defined diffraction peaks around $2\theta = 5.5, 10.7$ and 15.9° (Fig. 3a) and (Table 2). These well defined diffraction patterns correspond to an ordered, self-organized lamellae structure with an interlayer spacing, which is formed by parallel stacks of polymer main chains that are separated

by regions that are filled with the alkyl side-chains [23, 25-29]. The films spin-cast from DCB and CB solvents showed only the (100) diffraction patterns.

When P3HT polymer is blended with C₆₀ fullerene (Fig. 3b), the P3HT diffraction peaks for (100), (200) and (300), as well as the (220), (311), (222) and (331) diffraction peaks at 17.7, 20.9 and 21.7° associated with C₆₀ were only observed on the films spin cast from THF and chloroform, respectively [30]. The observed diffraction peaks for blend films spin-cast from chloroform and THF solutions illustrate that the P3HT material still maintains its structure and it is not hindered by the addition of C₆₀, due to their low boiling point (Table 1) which offers an advantage of fast solvent drying time to deposit highly crystalline P3HT film [31].

The low intensity (lower crystallinity) peaks observed for blends spin-coated from aromatic solvents, such as Toluene, DCB and CB, indicates that P3HT crystallization is hindered and disordered with an addition of C₆₀ fullerene. However, Kline et al. [32] found that P3HT films cast in xylene have substantially higher crystallinity than their chloroform counterparts. Considering, the above results (Fig. 3), it can be suggested that, the faster evaporation time and limited solubility of rr-P3HT and C₆₀ in both solvents (chloroform and THF solution) for spin-casting offers rr-P3HT and its blend to form a more kinetically favourable crystal structure and crystallization [31], where hexyl side chains of rr-P3HT are oriented parallel to the substrate, i.e., vertically π - π stacking of inter-rr P3HTs on the substrate

(inset in Fig. 3a). In addition, it can also be inferred that in the non-aromatic solvents the beam is more highly scattered due the substantial ordering of the polymer as well by C₆₀ clusters formation induced by lower solubility solvents in C₆₀. However, in the films spin-cast in aromatic solvents the scattered beam experiences a smooth interface between P3HT and C₆₀ induced by high solubility of C₆₀ in aromatic solvents (Table 1).

Using Bragg's equation [28, 29, 33, 34], the d-spacing for the primary (100) peak of P3HT and its blend was found to be between 1.55 and 1.65 ± 0.03 nm as shown in Table 2. Thus, comparing these values with the data from the literature [25, 33-38], it can be concluded, that the detected peak originates from polymer crystallites with *a*-axis orientation (backbone parallel and side-chains perpendicular to the substrate, as depicted in the inset in Figure 3(a)). The domain size along the *b* and *c* axes [28] could not be estimated from our measurements. Furthermore, using Scherrer's equation [33, 34] with the full width at half maximum (FWHM) of the (100) diffraction peak of the P3HT film revealed that the crystallite sizes of P3HT and blend films ranges between 9.0 and 15.0 ± 0.03 nm as presented in Table 2. An increase in crystal sizes (reduction in FWHM) was observed for the P3HT prepared from non-aromatic solvents. This indicates an increase in the ordering of the alkyl chains within the main thiophene chains. It was previously observed, using high resolution transmission electron microscopy (HR-TEM) as well as XRD, that that the structure of rr-P3HT films consists of crystallites embedded in an amorphous polymer matrix [22, 32, 39].

To complement XRD, Raman spectroscopy measurements were performed on spin-coated P3HT and P3HT: C₆₀ (1:1 wt. ratio) films. Figure

4 present the Raman spectra of the P3HT and its blend (1:1 wt. ratio) film prepared from different solvents. In the spectrum of P3HT (Fig. 4) intensive Raman bands at about 715 , 1380 and 1440 cm^{-1} are observed and are assigned to the C–S–C ring deformation, C–C skeletal stretching and C=C ring stretching, respectively [40-42]. However, no Raman features attributable to C_{60} , such as the A_{1g} 1469 cm^{-1} mode of fullerenes, could be resolved.

To investigate the effect of solvents on the structural properties of P3HT, we compare the 1350-1500 cm^{-1} region for non-aromatic and aromatic solvents. A Lorentzian function was carried out on the Raman spectra around 1445 cm^{-1} and the data are summarized in Table 3. For rr-P3HT films prepared from non-aromatic solvents (Fig. 4a), an increase on the intensity of C=C ring stretching bands is observed, indicating an ordering in the polymer. However, when P3HT is blended with C_{60} fullerene (Fig. 4b), significant changes on the C=C stretching deformation is observed. The peak position shifts to higher wavenumbers (cm^{-1}) and the FWHM also increased with the addition of C_{60} . A downward shift in the wavenumber generally indicates an increase in the crystallinity of P3HT polymer and the extension of the effective conjugation length along the polymer backbone [43]. Similar results were also observed by Malgas et al. [44].

Figure 5 presents Fourier transform infrared spectroscopy (FTIR) absorbance spectra of P3HT and blended films measured in the range of 4000–400 cm^{-1} . The absorption band at 3054 cm^{-1} is assigned to aromatic CH stretching. This band is only observed for the P3HT films prepared from

chloroform, indicating better ordering on the polymer structure. However, for the P3HT:C₆₀ (1:1 wt. ratio) film (Fig. 5b), this band disappears, which is probably due to the addition of the C₆₀ fullerene. The bands around 2921, 2935 and 2854 cm⁻¹ are assigned to aliphatic CH stretching; while the bands at 1460 and 1510 cm⁻¹ are associated with symmetric and asymmetric ring stretching vibrations, respectively. The relative intensity ratio of the 1510 cm⁻¹ band to the 1460 cm⁻¹ band (I_{1508}/I_{1460}) provides information on the P3HT the conjugation length [45, 46]. In brief, conjugation length is the length of a completely undisturbed alternating single bond / double bond segment, being planar and allowing maximum overlap of π -electrons. In the present case for as-prepared P3HT prepared from different solvents, the I_{1508}/I_{1460} ratios ranges between 0.25 and 2.0.

The absorption bands at 1377, 819 and 725 cm⁻¹ corresponds to the methyl deformation, aromatic C-H out-of plane and to the methyl rocking. The band at 1045 cm⁻¹ are assigned to C=S⁺-O⁻ residues [47]. The films prepared from chloroform and THF as depicted in the inset (Fig. 5) shows enhanced intensity on the aromatic C-H out-of plane and this band can be used to study the charge-transfer effect in P3HT. However, no significant changes, such as shifting of the peaks were observed on the bands. A new band appears (inset Fig. 5a) at 798 cm⁻¹ and disappears for the blended films. Gustafsson *et al.* [48] observed two peaks (at 2480 and 774 cm⁻¹) for fully FeCl₃ doped P3HT and assigned them to the formation of bi-polarons.

Therefore, we can conclude that, higher surface roughness, the presence of nanorod structures (Fig. 1), and an increase on the intensity of C=C ring stretching bands (Fig. 4) provide evidence of the better ordering of the polymer matrix in the fast drying solvents, which confirm the enhanced crystallinity observed in the corresponding XRD spectra (Fig. 3).

3.3. Optical properties

Figure 6 depicts the UV-vis absorption spectra of the rr-P3HT film and its blend of P3HT:C₆₀ (1:1 wt. ratio) prepared from different solvents. It is evident from Figure 6(a) that the films spin-coated in non-aromatic solvents have higher absorption intensity than the aromatic solvents. This indicates that the degree of the P3HT chain ordering intra-chain interactions is higher in the case of using non-aromatic solvents [35, 49, 50] and is in agreement with observations made from the structural analysis. The absorption maxima are observed at the wavelengths of between 522 and 560 nm, for the film prepared from aromatic solvents. However, for non-aromatic solvents, the absorption maxima were observed around 518 and 556 nm, respectively. These bands can be ascribed to the π - π^* transition [23]. The development of vibronic structures (i.e. the strong shoulders peaks) is also observed around 604 nm.

When P3HT is blended with C₆₀ (1:1 wt. ratio) as shown in Figure 6(b), an interesting effect was observed. The reduction in maximum absorption intensity and shifting in the wavelength was observed. This reduction in intensities and the shift might originate from a tighter chain coil, produced by twisting of the polymer backbone or broken conjugation in the presence of

C₆₀, resulting in segments with a shorter conjugation length and weaker interchain interaction. This result can also be explained by a change in the stacking conformation of the polymer structure from high crystallinity to lower crystallinity, and a reduction of intraplane and interplane stacking, which causes a poor π - π^* transition and lower absorbance. This reduction in intensities was also observed in the literature [51, 52].

Photoluminescence quenching in a bulk heterojunction (BHJ) is a useful indication of the degree of success of exciton dissociation. Figure 7 shows the PL spectra of P3HT and P3HT:C₆₀ (1:1 wt. ratio) films spin-coated from different solvents. It is apparent in Figure 7(a) that the films spin-coated from chloroform as well as in xylene solvent exhibit a reduced PL intensity. Upon introducing a C₆₀ fullerene as an acceptor material in the P3HT films (Fig. 7b) the PL is quenched by a factor of 3. It is also observed that the chloroform prepared film exhibits a red-shift, showing its maximum at 700 nm and a shoulder at 718 nm. The red-shift and the reduction in the PL intensity in the case of chloroform is probably due to less coarse phase separation, which promote the C₆₀ to be in close enough contact with the polymer to undergo a charge transfer.

Films spin-coated in other solvents, such as CB, xylene, DCB, and toluene solvents; reveal a higher PL intensity (incomplete quenching), showing that not all the excitons generated on one polymer within the film reached an interface with the other polymer. This is probably due to their higher solubility of the C₆₀ fullerene (Table 1) thereby inducing a finer phase separation and smaller grain size observed. Koeppe et al. [53] reported

that, in a finer phase separation, the photogenerated charge carriers overcome much more interfaces during their travel in a fine mixture. Therefore, it can be concluded that, the formation of inter-chain exciton and its easy dissipation to a long distance overcomes over exciton dissociation [54], as chain planarity/crystallinity (Fig. 3) increases and causes decrease in PL intensity. The PL quenching observed here is suggested to be a case of self-quenching, where plainer chains allow easy going/dissipation for excitons to a long distance (10-20nm). This will allow excitons to lose their energy and lessen the probability of radiative decay.

4. CONCLUSION

We have studied the effect of solvents on the phase separation, crystallization and interchain interaction of P3HT and C₆₀ fullerene films using AFM, XRD, UV-vis, PL, Raman and FTIR spectroscopy. A high surface roughness and degree of ordering on the polymer chain were observed. This indicates that the limited solubility of rr P3HT in a marginal solvent such as non-aromatic solvents can offer a strategy to obtain highly ordered crystal structures. A red-shift and a complete reduction (quenching) in the PL intensity as well as nanorod structure were observed in the films spin-cast from chloroform. The PL quenched by a factor of 3 after blending the P3HT with C₆₀ in a 1:1 wt. ratio using CB, xylene, DCB, and toluene as solvents, indicating a partially charge transfer from P3HT to C₆₀.

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Figure 1: D. E. Motaung *et.al.*

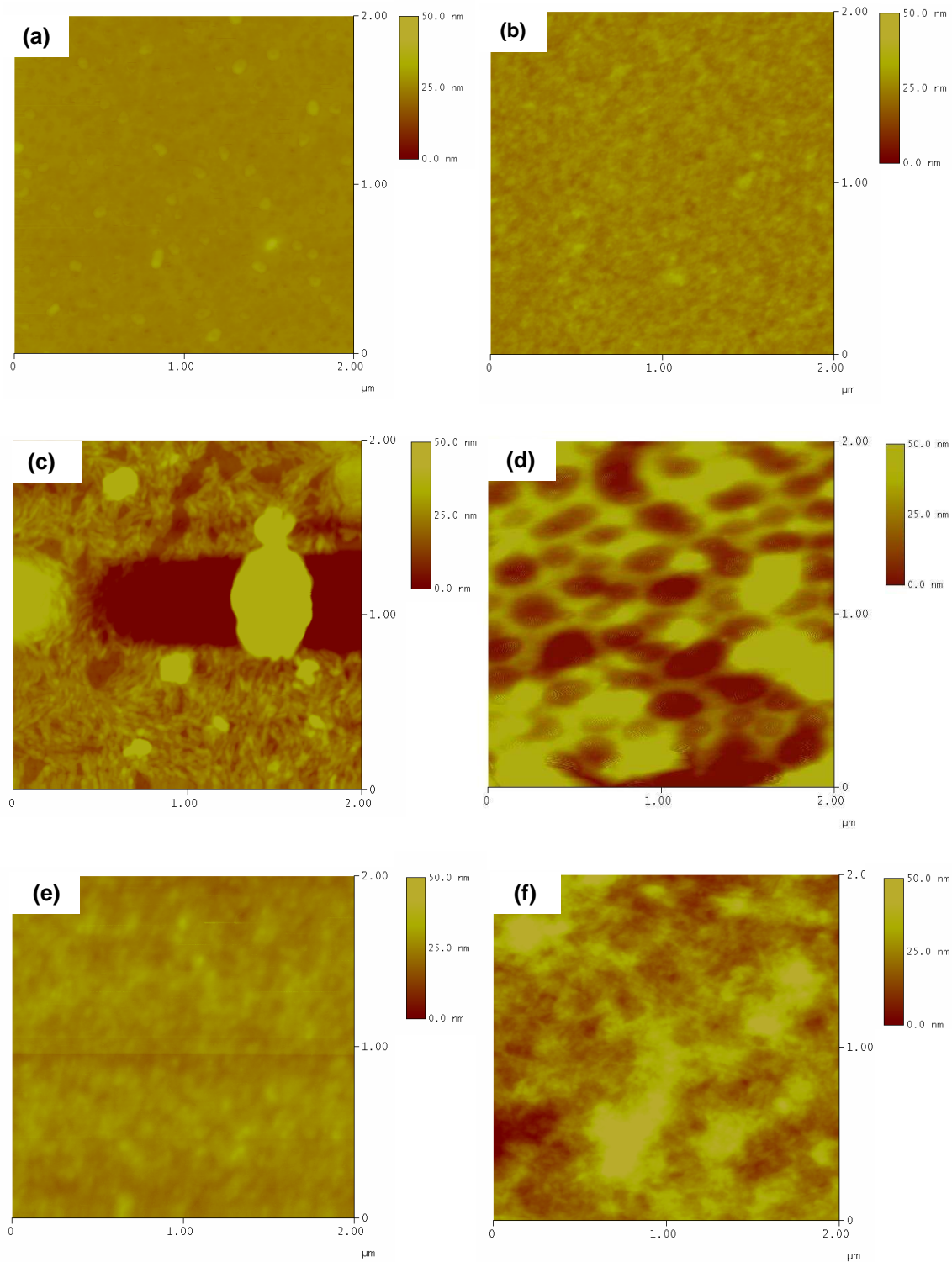


Figure 2: D. E. Motaung *et.al.*

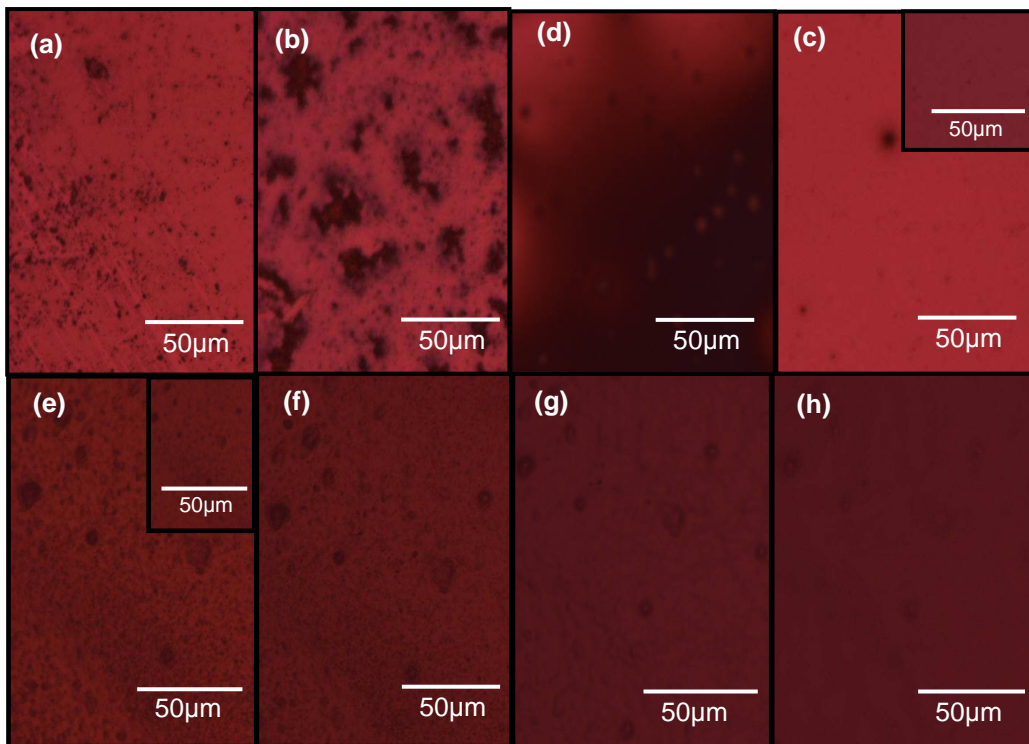


Figure 3: D. E. Motaung *et al.*

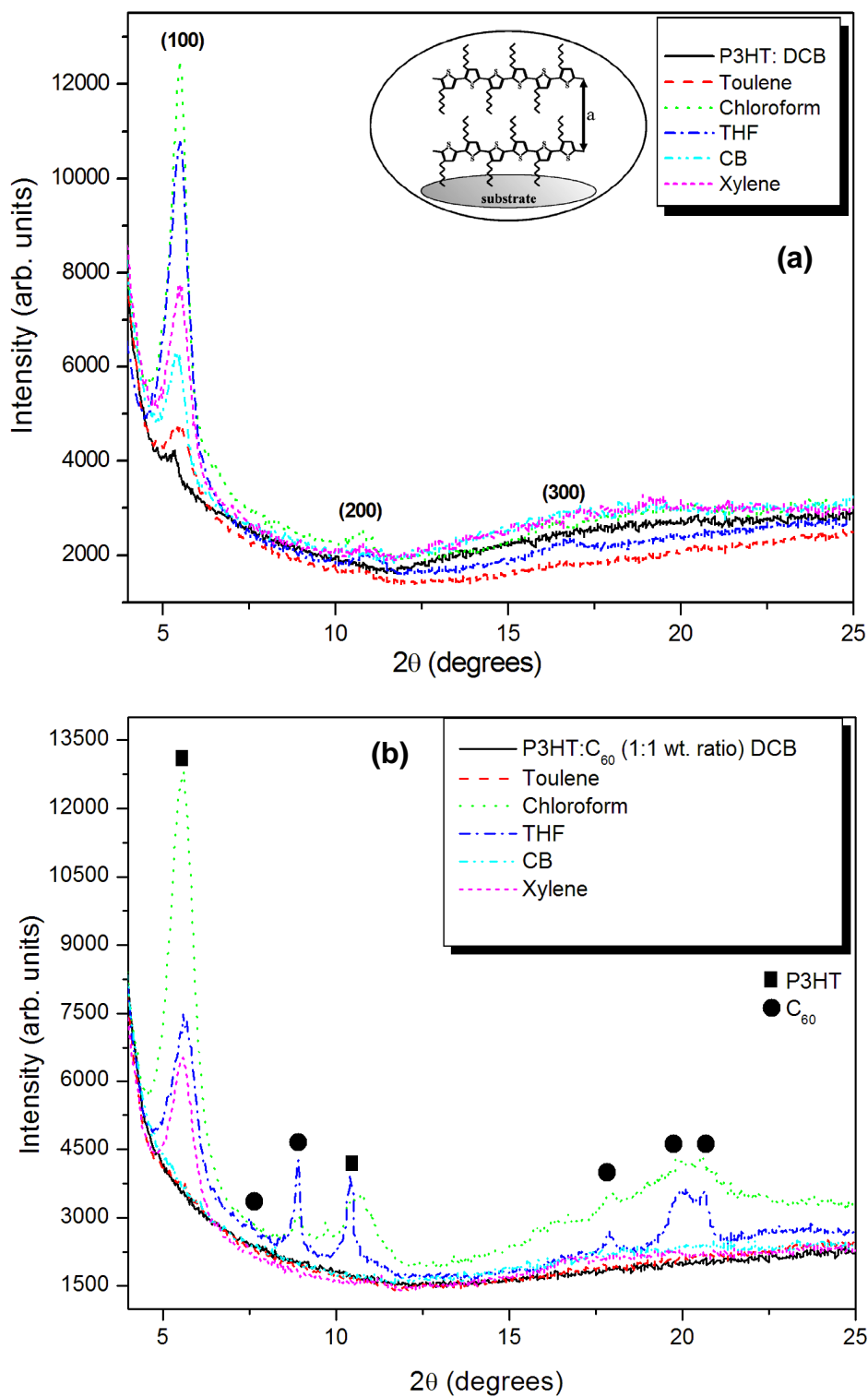


Figure 4: D. E. Motaung *et.al.*

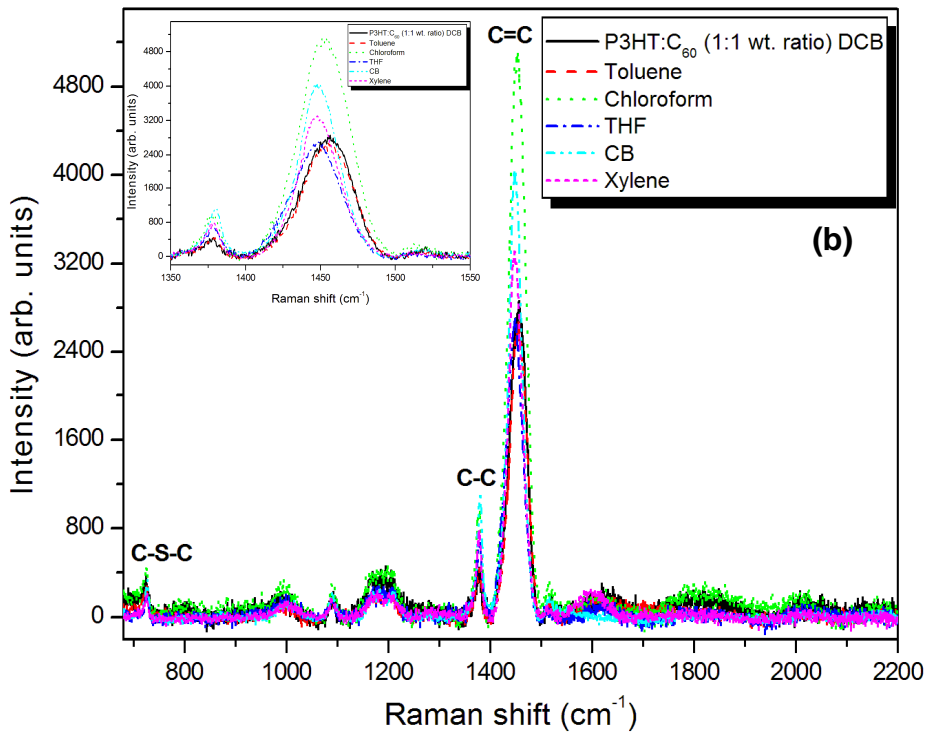
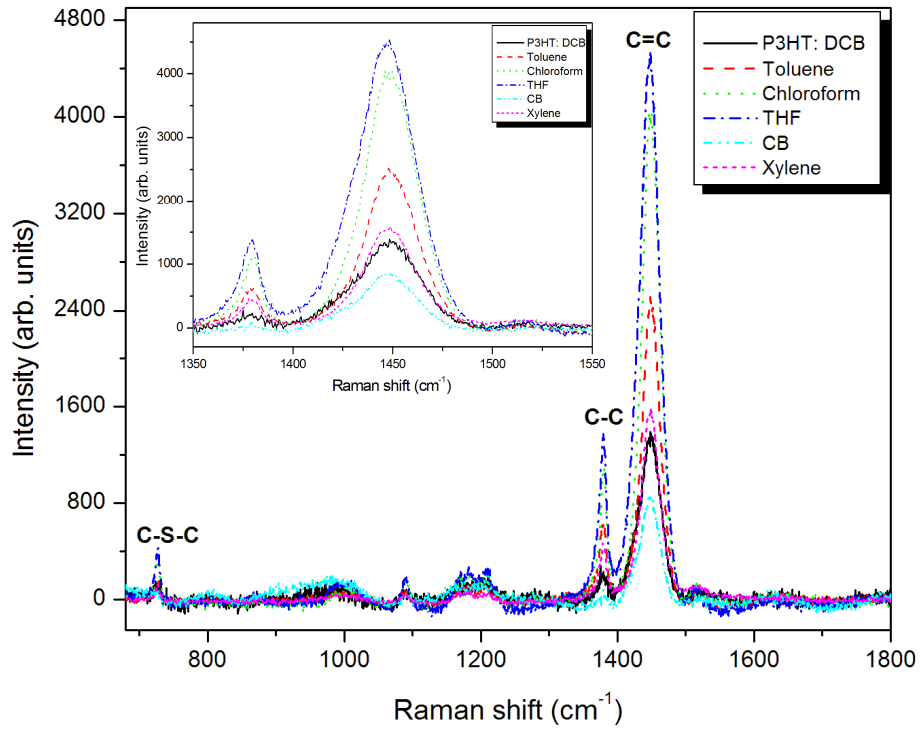


Figure 5: D. E. Motaung *et al.*

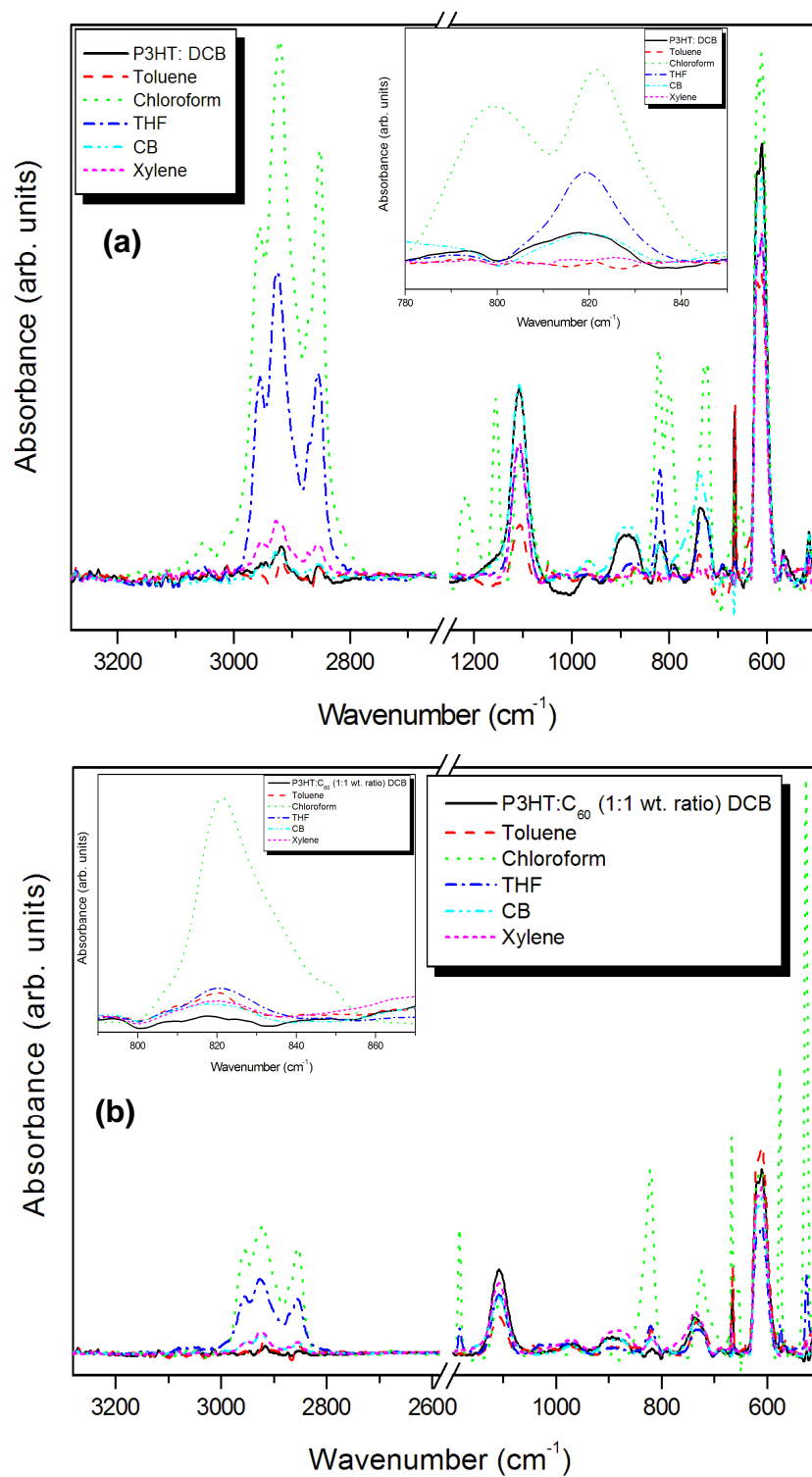


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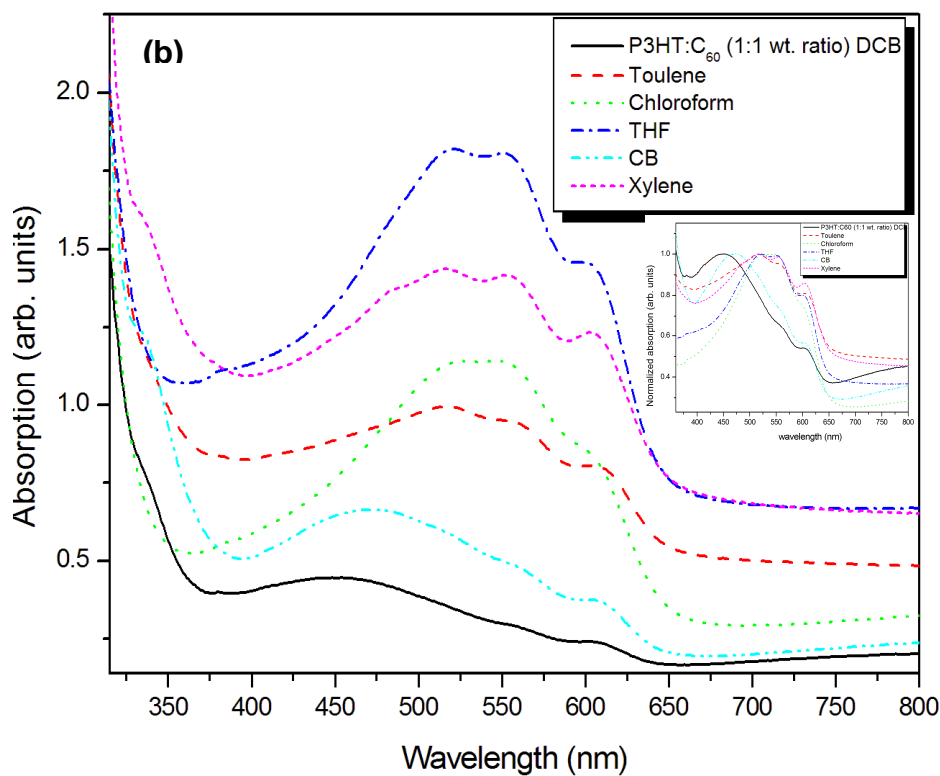
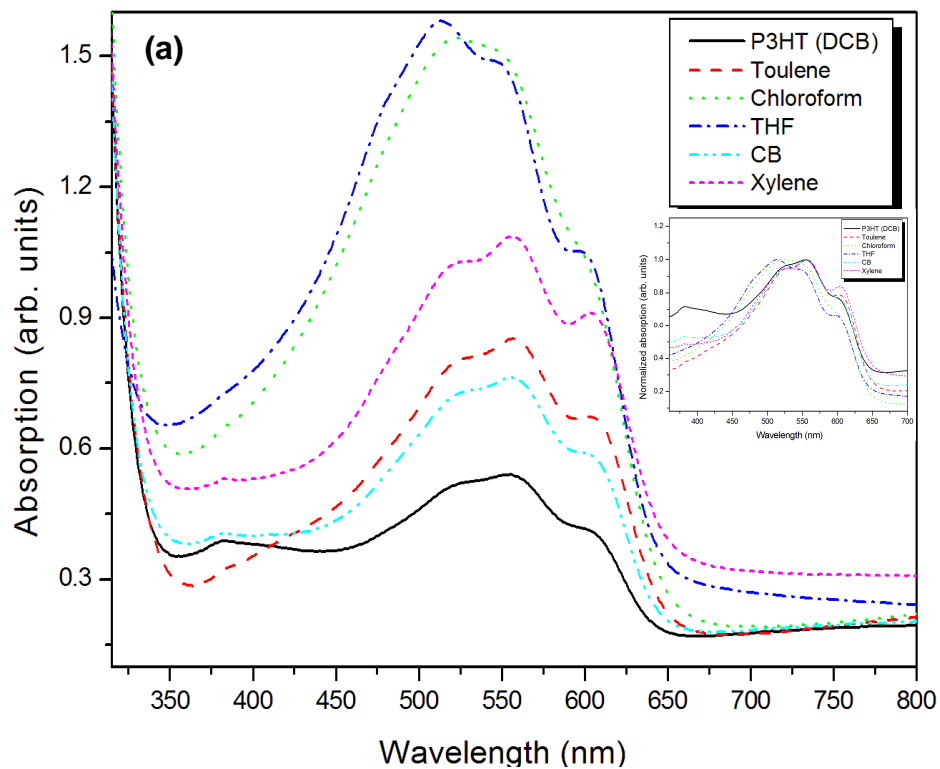


Figure 7: D. E. Motaung *et.al.*

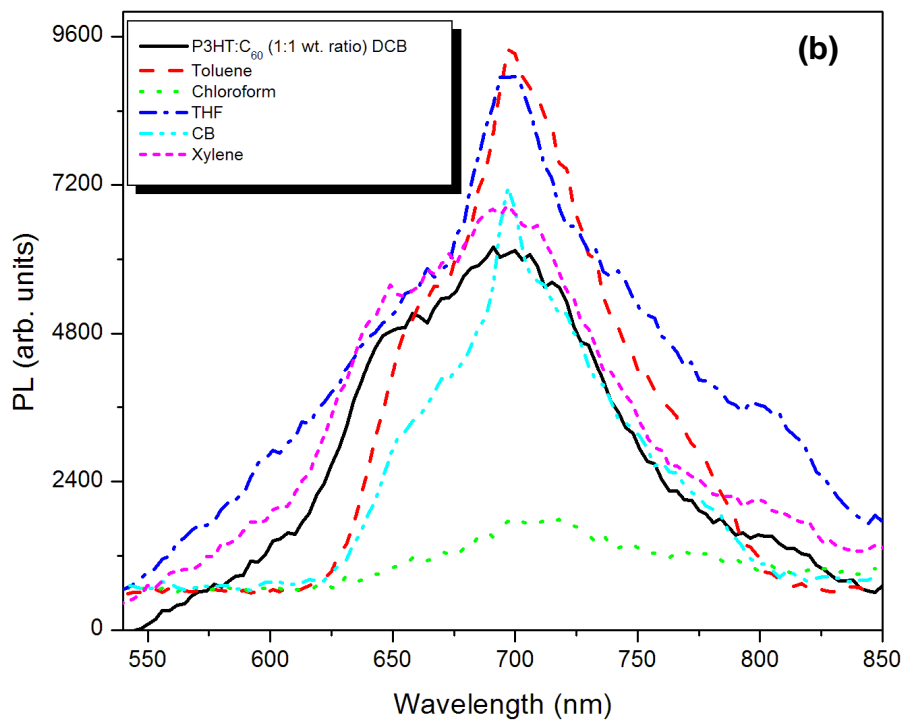
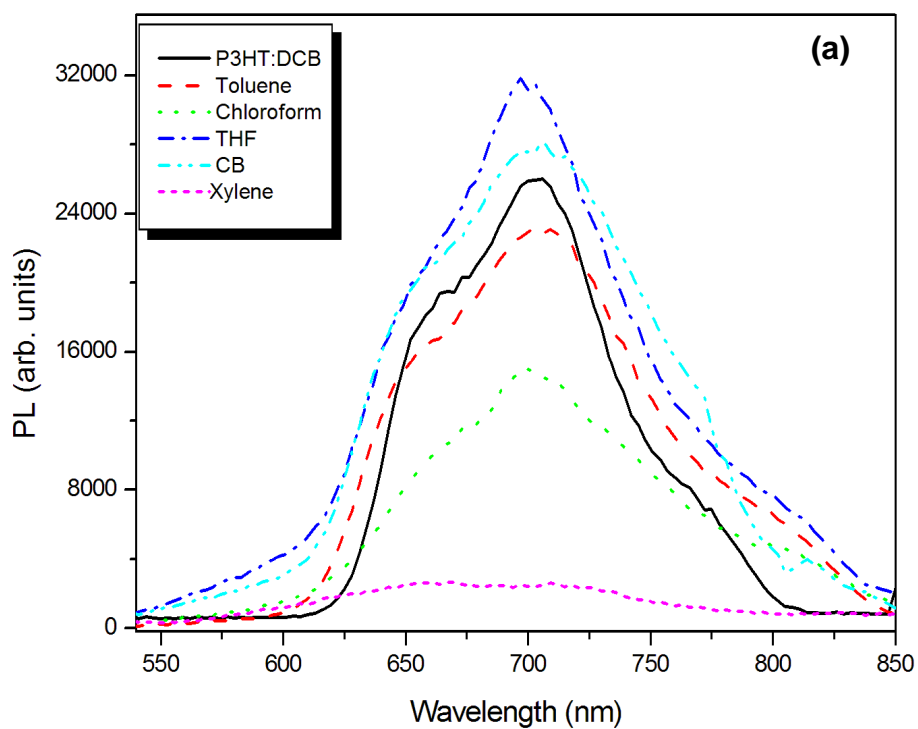


TABLE 1: D. E. Motaung *et. al.*

Solvents	Boiling points (°C)	C₆₀ Solubility (mg mL⁻¹)
Dichlorobenzene (DCB)	180.3	27.0
Chlorobenzene (CB)	111.0	7.0
Xylene	62.0	5.2
Toluene	66.0	2.8
Chloroform	132.0	0.16
THF	144.0	0.006

TABLE 2: D. E. Motaung *et.al.*

Solvents	Peak height (cts)	d-spacing (nm)	FWHM (°)	Grain size (nm)
DCB	1380.64	1.65	0.82	9.7
Toluene	2109.29	1.59	0.77	10.3
Chloroform	8853.56	1.59	0.56	14.2
THF	8108.1	1.55	0.60	13.3
CB	3384.48	1.61	0.65	12.2
Xylene	4707.01	1.59	0.71	11.2

TABLE 3: D. E. Motaung *et.al.*

Solvents	P3HT film			P3HT: C ₆₀ (1:1 wt. ratio) film		
	Peak position (cm ⁻¹)	FWHM (cm ⁻¹)	Intensity (a. u)	Peak position (cm ⁻¹)	FWHM (cm ⁻¹)	Intensity (a. u)
DCB	1447.7	31.035	1401.8	1454.2	46.366	3599.3
Toluene	1449.0	33.986	2878.0	1454.8	44.399	3313.0
Chloroform	1448.7	33.993	4682.2	1452.5	47.708	6579.9
THF	1447.5	38.859	5174.2	1449.4	44.337	3280.3
CB	1447.6	38.307	1005.6	1448.9	34.530	4634.2
Xylene	1448.2	32.508	1724.0	1448.8	36.234	3930.8

List of Tables and Figure captions

Figure 1: Tapping-mode AFM topography scans ($2\mu\text{m}\times 2\mu\text{m}$) of as-prepared P3HT:C₆₀ (1:1 wt. ratio) films prepared from different solvents **(a)** DCB, **(b)** Toluene, **(c)** Chloroform, **(d)** THF, **(e)** Chlorobenzene and **(f)** Xylene solution.

Figure 2: Polarized optical microscopy micrographs of the surface of a P3HT:C₆₀ (1:1 wt. ratio) prepared from different solvents: **(a)** Toluene, **(b)** THF, **(c)** Xylene **(d)** CB (inset DCB) and **(e-h)** Chloroform. The images in **e–h** correspond to temperatures of 72, 170, 200 and 250 °C, respectively. Note images in **a-d**, as well as the inset in **(e)** were taken at room temperature.

Figure 3: Diffraction patterns of (a) rr-P3HT and (b) P3HT:C₆₀ (1:1 wt. ratio) blend prepared from different solvents. The inset depicts the orientation of the P3HT crystalline domains with respect to the substrate (Fig 4a).

Figure 4: Raman spectrum of (a) P3HT film, as well as its blend, (b) 1:1 wt. ratio, prepared from different solvents and spin-coated on Si substrate.

Figure 5: FITR spectra of (a) P3HT film, as well as its blend, (b) 1:1 wt. ratio, prepared from different solvents and spin-coated on Si substrates.

Figure 6: UV-vis absorption spectra of **(a)** pure P3HT film, **(b)** P3HT:C₆₀ (1:1 wt. ratio) blend prepared from different solvents and spin-coated on ITO glass substrates.

Figure 7: Photoluminescence (PL) spectra of (a) P3HT film and (b) P3HT:C₆₀ blend film spin cast from different solvents on Si (100) substrates. Variation in intensity is observed for different solvents.

Table 1: Boiling points of different solvents and their solubility in C₆₀ fullerene [19, 20].

Table 2: Summary of the peak positions and grain sizes of the as-prepared P3HT films prepared from different solvents.

Table 3: Raman measurements of the C=C stretching deformations for the P3HT film and its blend (1:1 wt. ratio) prepared from different solvents and spin-coated on Si substrates.